Low-Cost Chip Microprobing

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#### A few smart cards chips cover numerous security domains

#### **Security chip applications**



Payment cards, electronic ID cards, access badges



Trusted platform modules (TPM)



Device and accessory identification



SIM cards, NFC secure elements



Content protection

#### **Chip hacking motivation**

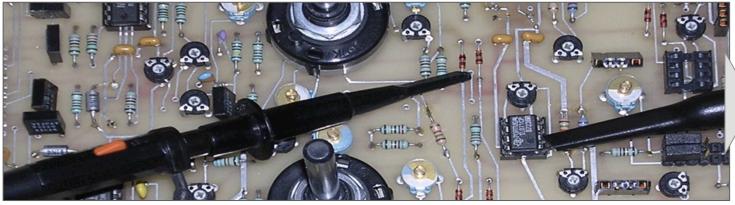
- Recent trend –
   Functionality that users traditionally circumvented or exposed in their devices moves into hardware:
  - Usage restrictions
  - DRM, "Dongeling"
  - "Secret" protocols
- Devices are increasingly controlled by their manufacturer, not their owner
- We need more wide-spread hardware analysis knowledge and cheaper tools to combat this trend



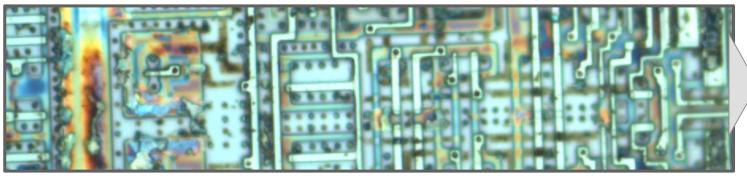
#### Reverse-engineering hardware functions requires specific tools



Disassamler, decompiler



Oscilloscope, logic analyzer

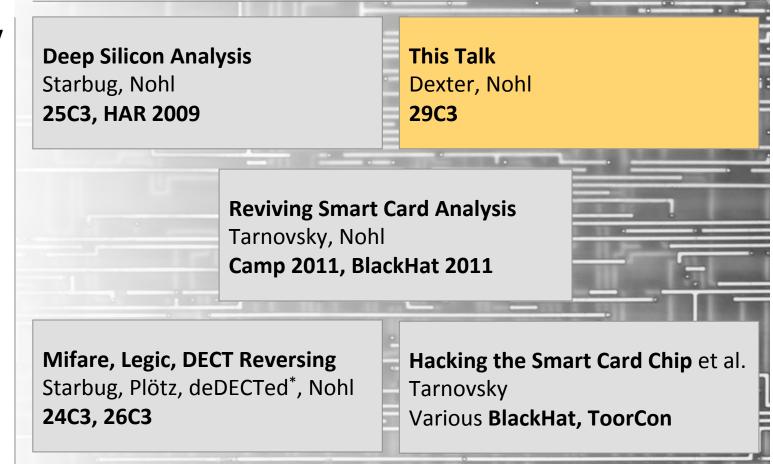


Microscope, micropositioner (this talk's focus)

# This talk introduces the methodology and tools of earlier (and hopefully future) works

#### Reverse-engineer chip functionality Read out memories

#### Introductory



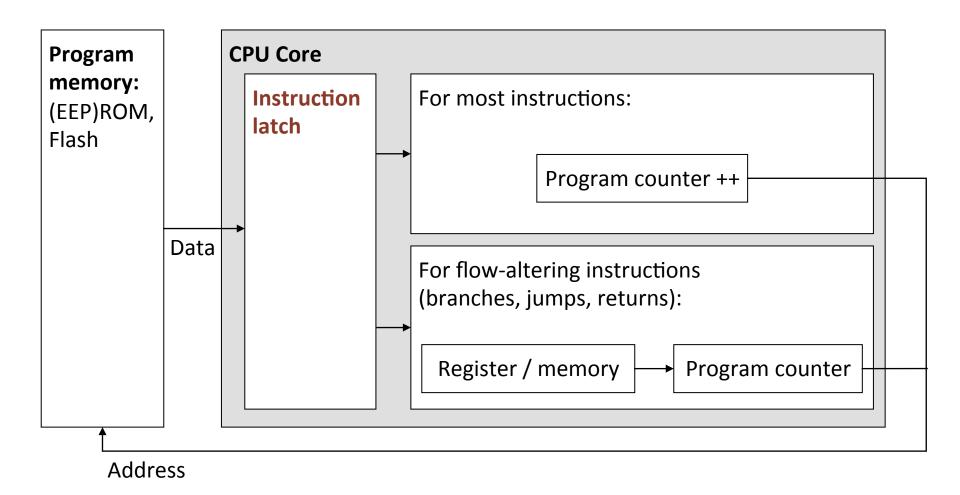
**Advanced** 

## Microprobing background

- Probing with simple tools
- Advanced probing techniques

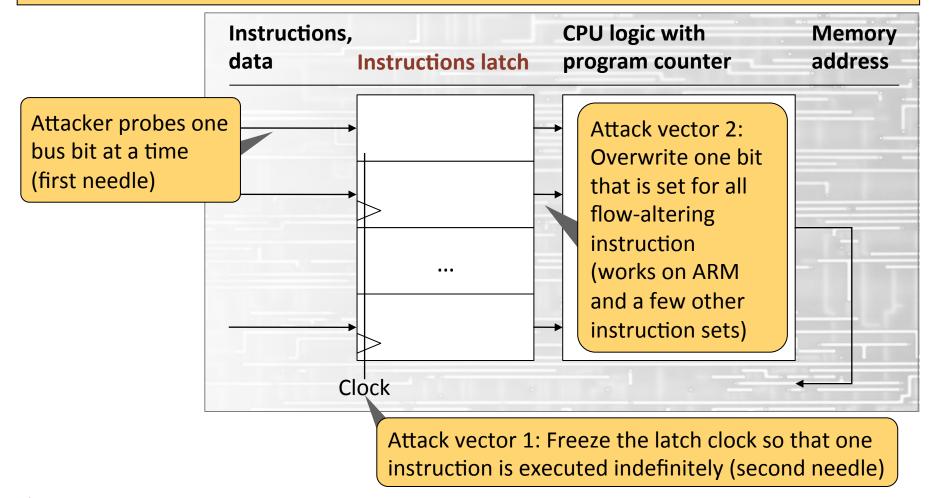


# Basic CPU principle: Current instruction decides which instruction gets loaded next



## Probing and glitching with only two needles allows full memory read-out

Attacker goal: Make the CPU go to all places in memory independent of security checks and other flow characteristics. This attack is called **Linear Code Extraction**.



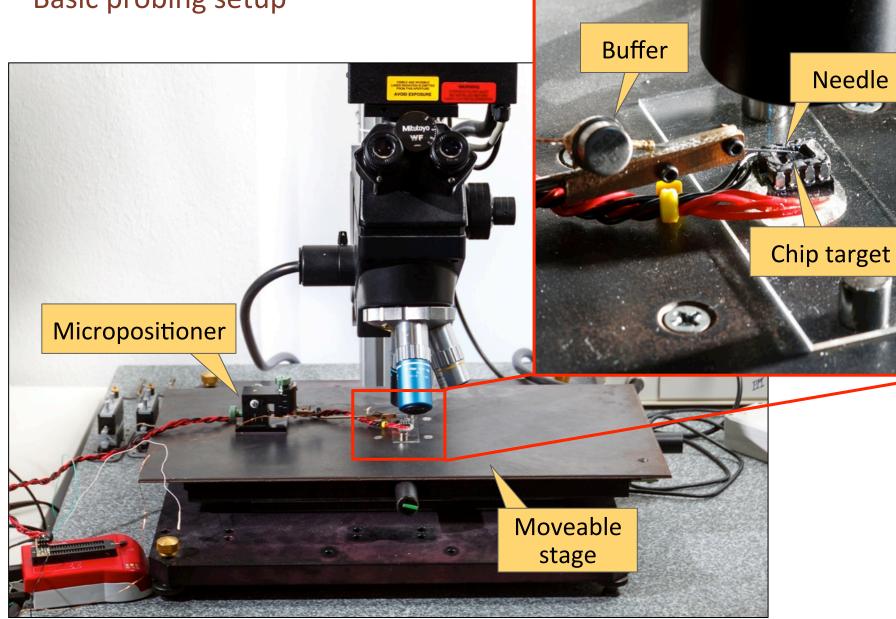
Microprobing background



Advanced probing techniques



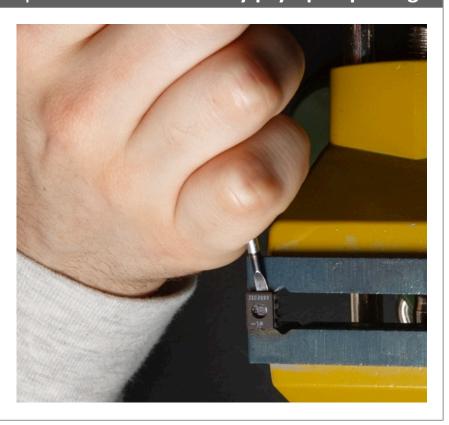
## Basic probing setup



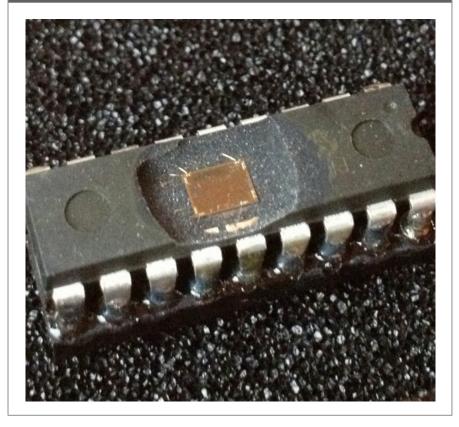


## Step 1: Decapsulate chip

Option A – Mechanically pry open package



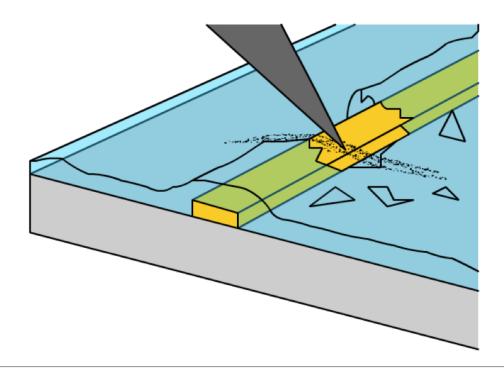
Option B – Chemically etch into package

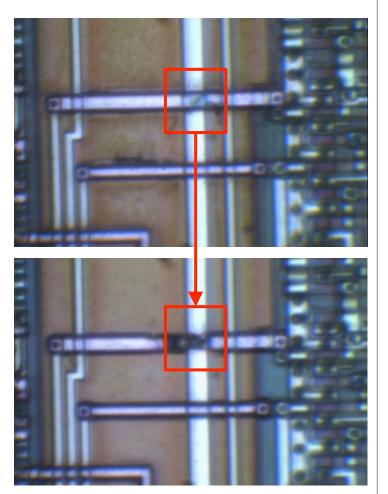


#### Step 2: Expose wires (1/2)

#### Option A – **Scratching**

- A micropositioner in combination with hard needles can break the silicon oxide (aka glass) above metal tracks
- Works best for highest ("top") metal layer on non-planarized chips





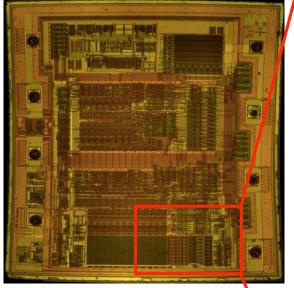
### Step 2: Expose wires (2/2)

#### Option B – Lasering

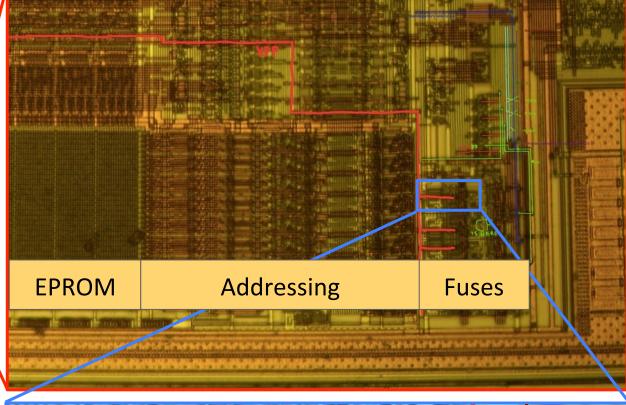
- A laser shot through the microscope destroys chip structures to:
  - Expose wires for probing -or-
  - Cut wires to alter chip logic;
     i.e. permanently reset lock bit
- Optimal for planarized chips and for working on top metal
- Takes practice to not destroy chips through shorting wires or inducing overvoltage
- Higher cost alternative when compared to scratching but more reliable after practice

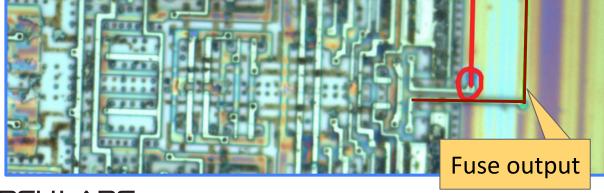


#### Step 3: Find exploitable wires

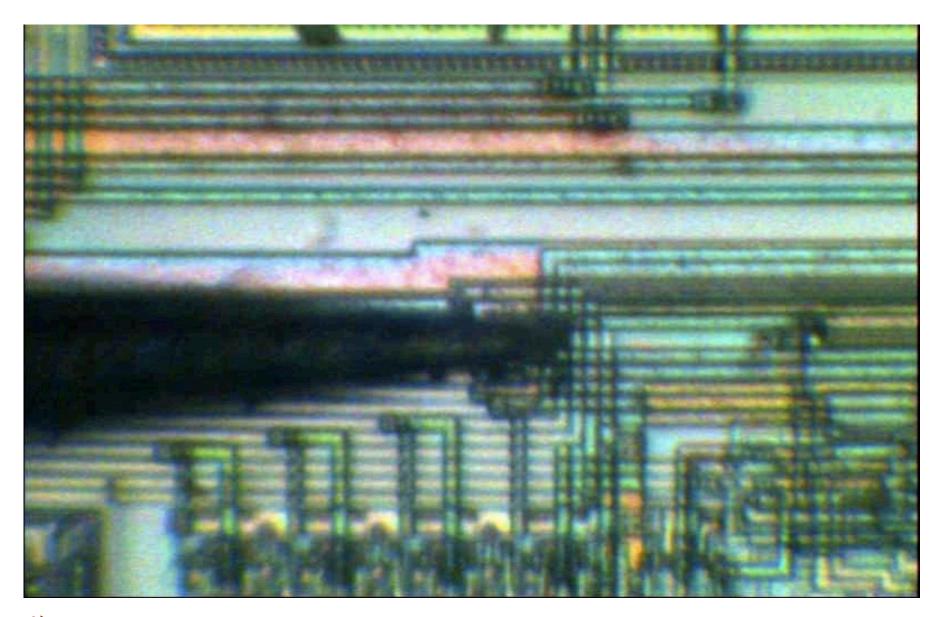


- Most interesting chip structures:
  - Security bits (fuses)
  - Data buses
- Discover them:
  - Reverse-engineer(HAR 09, Camp 11)
  - Trial and error

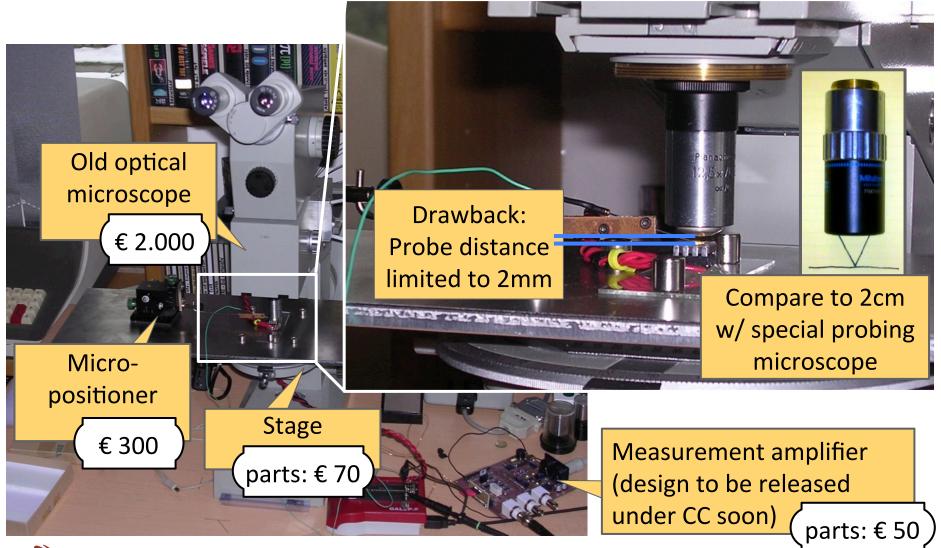




Step 4: Connect to wires with probing needle

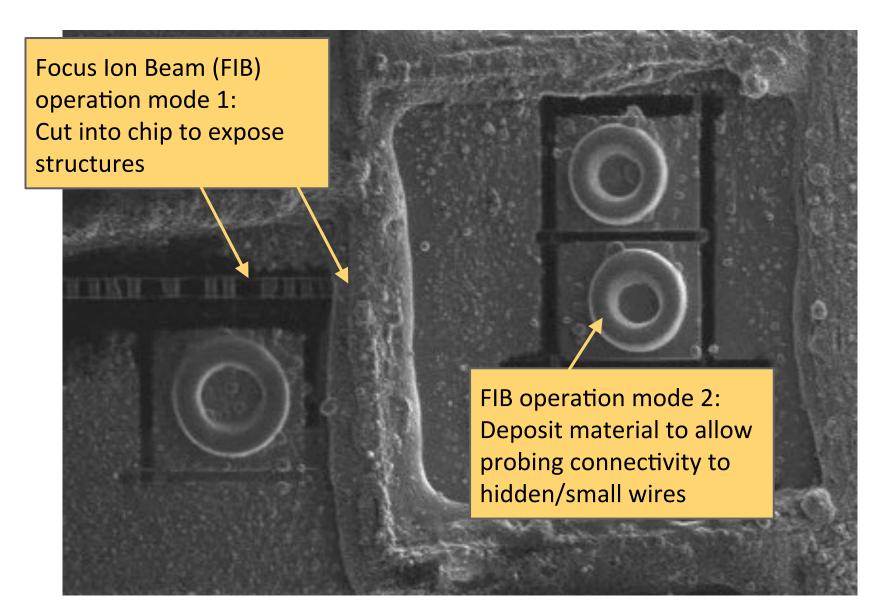


# Some level of probing can even be done with simple optical microscopes and few extra components

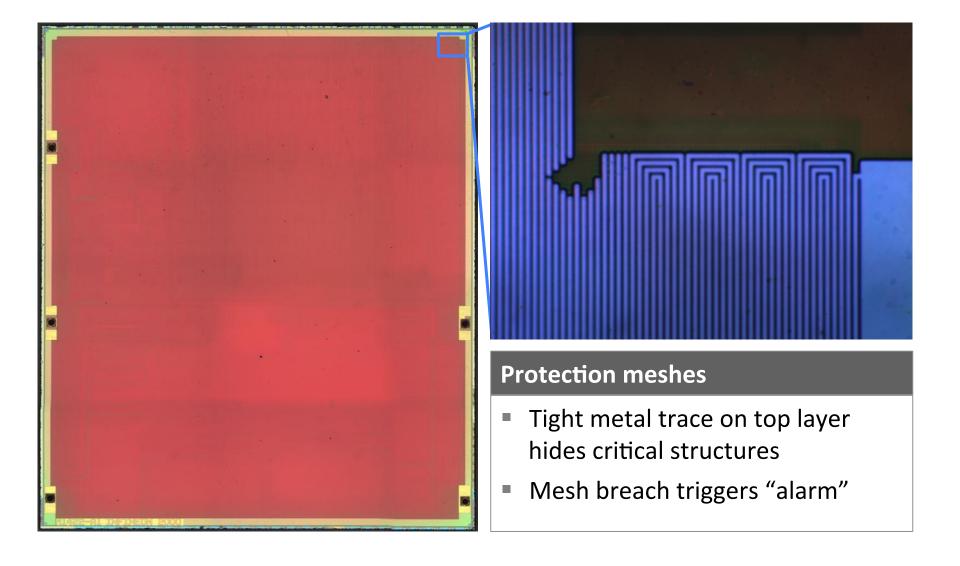


- Microprobing background
- Probing with simple tools
- Advanced probing techniques

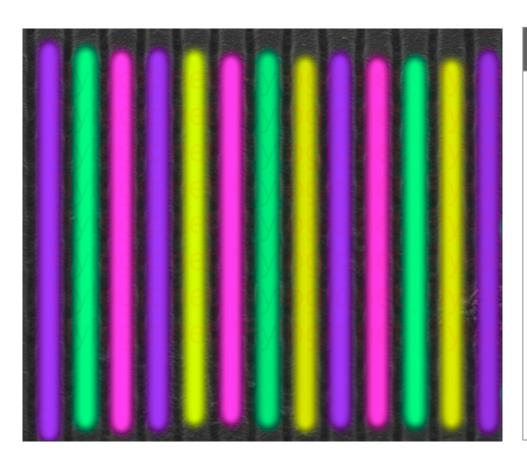
## Focused Ion Beams prepare small feature-size chips for probing



#### Protection meshes create additional complexity for FIB probing



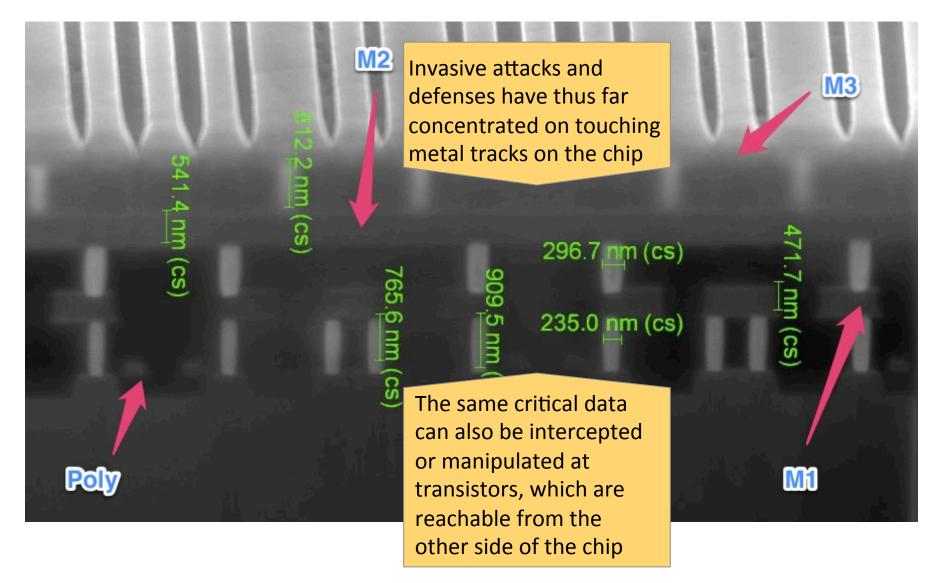
#### Meshes slow down attack, but do not prevent them



#### Mesh circumvention

- Either remove parts of mesh, then bridge/fix the mesh with FIB edits -or-
- Circumvent mesh alarm:
  - If defense is bulk-erase of non-volatile memory: Cut off the programming pumps
  - If chip it is logic reset: Exploit in the small time window before the reset triggers

## Arms race around front-side FIB attacks makes back-side attacks more attractive



#### Take aways

- Device functionality is increasingly hidden in hardware and needs to be freed
- Software can be extracted from chips using fuse overwrites or linear code extraction
- Simple controllers can be attacked with cheap tools; smart cards require focused ion beams

#### Questions?

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